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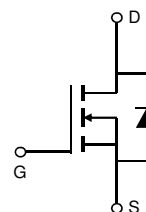
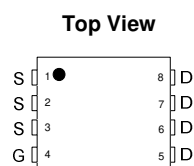
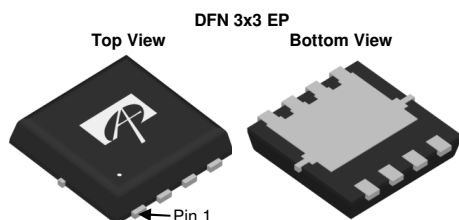
### General Description

The AON7432 combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ . This device is ideal for load switch and battery protection applications.

### Product Summary

|                                  |                |
|----------------------------------|----------------|
| $V_{DS}$                         | 30V            |
| $I_D$ (at $V_{GS}=10V$ )         | 18A            |
| $R_{DS(ON)}$ (at $V_{GS}=10V$ )  | < 15m $\Omega$ |
| $R_{DS(ON)}$ (at $V_{GS}=4.5V$ ) | < 18m $\Omega$ |
| $R_{DS(ON)}$ (at $V_{GS}=2.5V$ ) | < 24m $\Omega$ |

100% UIS Tested  
 100%  $R_g$  Tested



### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter                                      | Symbol         | Maximum    | Units            |
|--|----------------|------------|------------------|
| Drain-Source Voltage                           | $V_{DS}$       | 30         | V                |
| Gate-Source Voltage                            | $V_{GS}$       | $\pm 12$   | V                |
| Continuous Drain Current <sup>G</sup>          | $I_D$          | 18         | A                |
| $T_C=25^\circ\text{C}$                         |                | 14         |                  |
| Pulsed Drain Current <sup>C</sup>              | $I_{DM}$       | 60         |                  |
| Continuous Drain Current                       | $I_{DSM}$      | 10.5       | A                |
| $T_A=25^\circ\text{C}$                         |                | 8.5        |                  |
| Avalanche Current <sup>C</sup>                 | $I_{AS}$       | 17         | A                |
| Avalanche energy $L=0.1\text{mH}$ <sup>C</sup> | $E_{AS}$       | 14         | mJ               |
| Power Dissipation <sup>B</sup>                 | $P_D$          | 20.8       | W                |
| $T_C=25^\circ\text{C}$                         |                | 8.3        |                  |
| Power Dissipation <sup>A</sup>                 | $P_{DSM}$      | 3.1        | W                |
| $T_A=25^\circ\text{C}$                         |                | 2          |                  |
| Junction and Storage Temperature Range         | $T_J, T_{STG}$ | -55 to 150 | $^\circ\text{C}$ |

### Thermal Characteristics

| Parameter                                  | Symbol          | Typ | Max | Units              |
|--|-----------------|-----|-----|--------------------|
| Maximum Junction-to-Ambient <sup>A</sup>   | $R_{\theta JA}$ | 30  | 40  | $^\circ\text{C/W}$ |
| $t \leq 10\text{s}$                        |                 |     |     |                    |
| Maximum Junction-to-Ambient <sup>A,D</sup> | $R_{\theta JA}$ | 60  | 75  | $^\circ\text{C/W}$ |
| Steady-State                               |                 |     |     |                    |
| Maximum Junction-to-Case                   | $R_{\theta JC}$ | 5   | 6   | $^\circ\text{C/W}$ |
| Steady-State                               |                 |     |     |                    |

**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter  | Conditions  | Min | Typ        | Max      | Units |
|-----------------------------|--|---|-----|------------|----------|-------|
| <b>STATIC PARAMETERS</b>    |  |   |     |            |          |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage                     | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V  | 30  |            |          | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current                    | V <sub>DS</sub> =30V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                         |     |            | 1<br>5   | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current                          | V <sub>DS</sub> =0V, V <sub>GS</sub> =±12V  |     |            | ±100     | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                             | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA                                  | 0.6 | 1.07       | 1.5      | V     |
| I <sub>D(ON)</sub>          | On state drain current                             | V <sub>GS</sub> =10V, V <sub>DS</sub> =5V   | 60  |            |          | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance                  | V <sub>GS</sub> =10V, I <sub>D</sub> =10.5A<br>T <sub>J</sub> =125°C                      |     | 12.5<br>20 | 15<br>24 | mΩ    |
|                             |  | V <sub>GS</sub> =4.5V, I <sub>D</sub> =8A   |     | 14         | 18       | mΩ    |
|                             |  | V <sub>GS</sub> =2.5V, I <sub>D</sub> =4A   |     | 18         | 24       | mΩ    |
| g <sub>FS</sub>             | Forward Transconductance                           | V <sub>DS</sub> =5V, I <sub>D</sub> =10.5A  |     | 50         |          | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                              | I <sub>S</sub> =1A, V <sub>GS</sub> =0V   |     | 0.7        | 1        | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current <sup>G</sup> |   |     |            | 18       | A     |
| <b>DYNAMIC PARAMETERS</b>   |  |   |     |            |          |       |
| C <sub>iss</sub>            | Input Capacitance                                  | V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz   |     | 813        |          | pF    |
| C <sub>oss</sub>            | Output Capacitance                                 |   |     | 98         |          | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance                       |   |     | 56         |          | pF    |
| R <sub>g</sub>              | Gate resistance                                    | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz  | 1.1 | 2.3        | 3.5      | Ω     |
| <b>SWITCHING PARAMETERS</b> |  |   |     |            |          |       |
| Q <sub>g(10V)</sub>         | Total Gate Charge                                  | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =10.5A                         |     | 18         | 26       | nC    |
| Q <sub>g(4.5V)</sub>        | Total Gate Charge                                  |   |     | 8          | 12       | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                                 |   |     | 1.2        |          | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                                  |   |     | 2.6        |          | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                                  | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, R <sub>L</sub> =1.4Ω,<br>R <sub>GEN</sub> =3Ω |     | 3          |          | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                                  |   |     | 3          |          | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                                 |   |     | 26         |          | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                                 |   |     | 3.5        |          | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time                   | I <sub>F</sub> =10.5A, dI/dt=100A/μs  |     | 14         |          | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge                 | I <sub>F</sub> =10.5A, dI/dt=100A/μs  |     | 2.6        |          | nC    |

A. The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> t ≤ 10s value and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150° C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub>=25° C.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.

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# TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

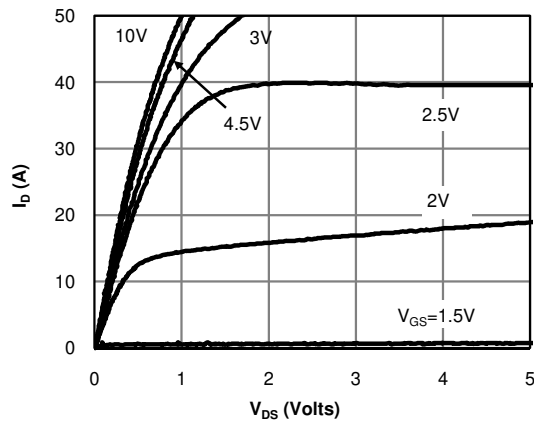


Fig 1: On-Region Characteristics (Note E)

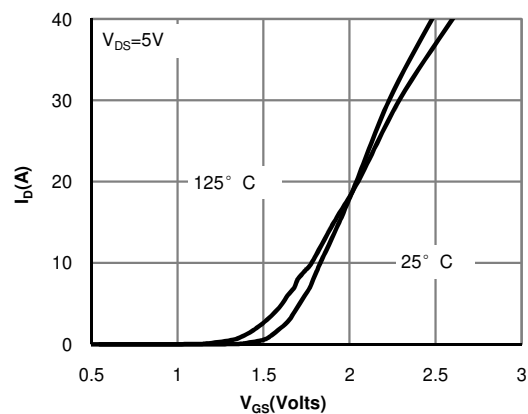


Figure 2: Transfer Characteristics (Note E)

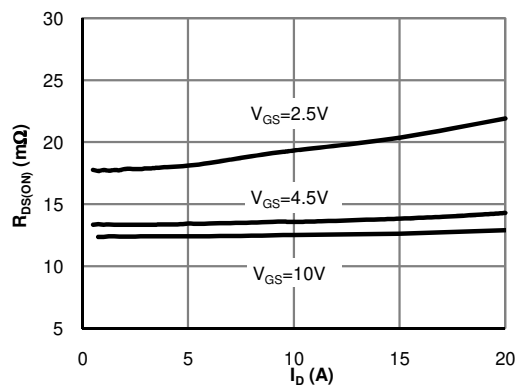


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

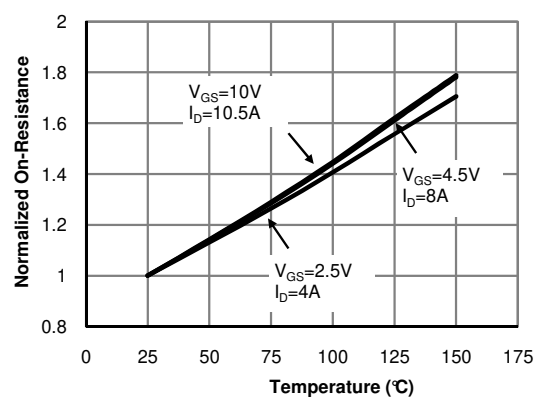


Figure 4: On-Resistance vs. Junction Temperature (Note E)

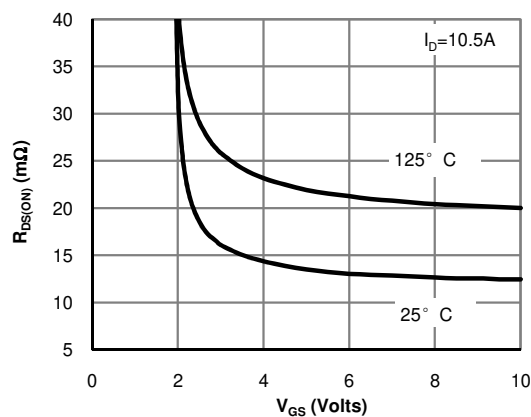


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

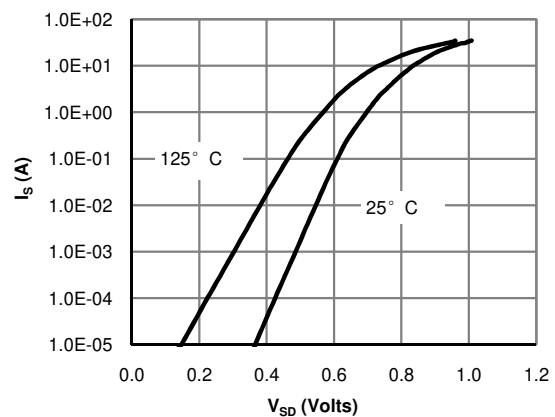


Figure 6: Body-Diode Characteristics (Note E)

# TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

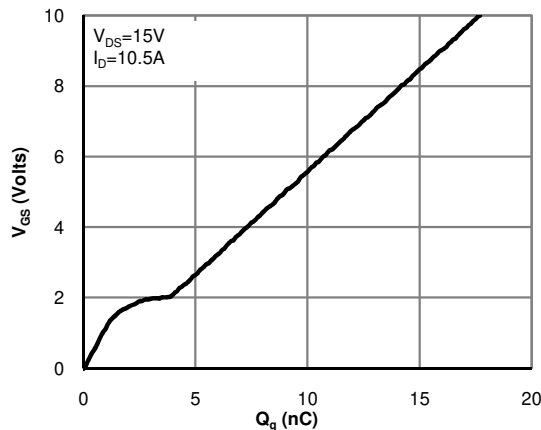


Figure 7: Gate-Charge Characteristics

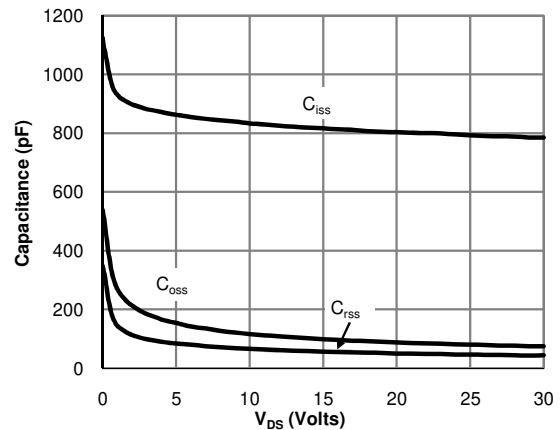


Figure 8: Capacitance Characteristics

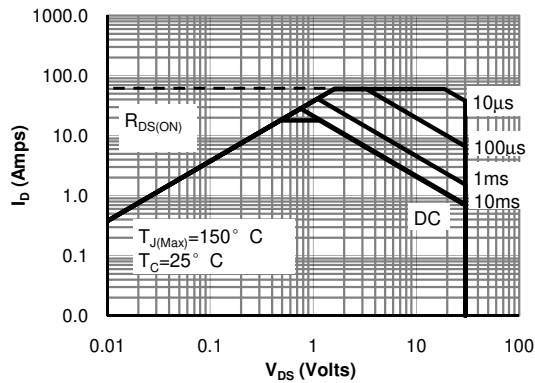


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

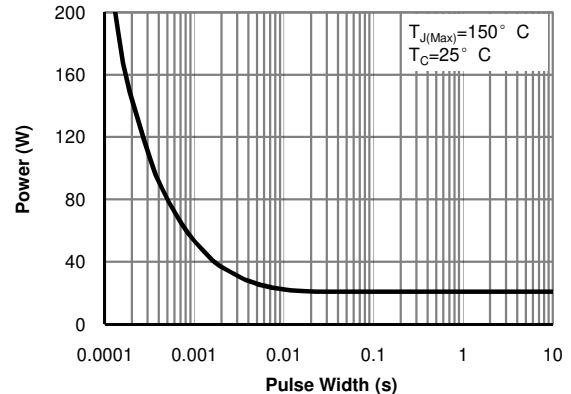


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

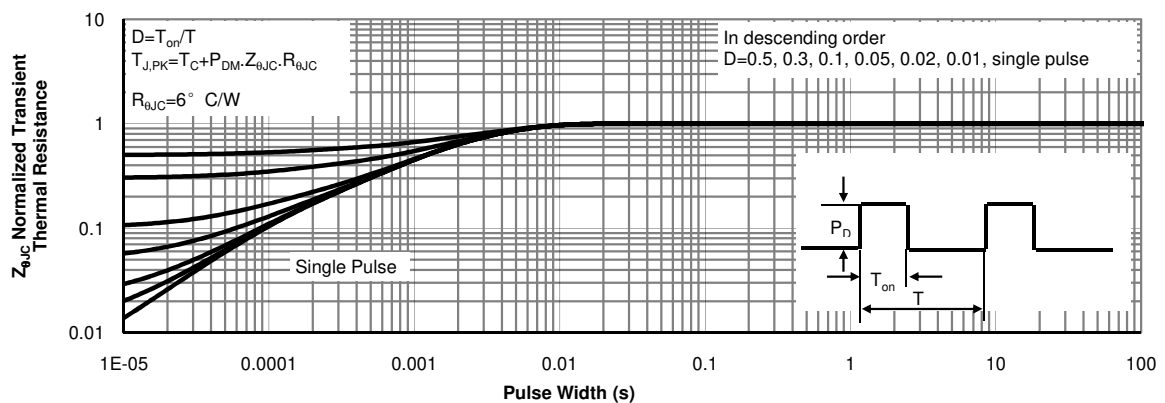


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

# TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

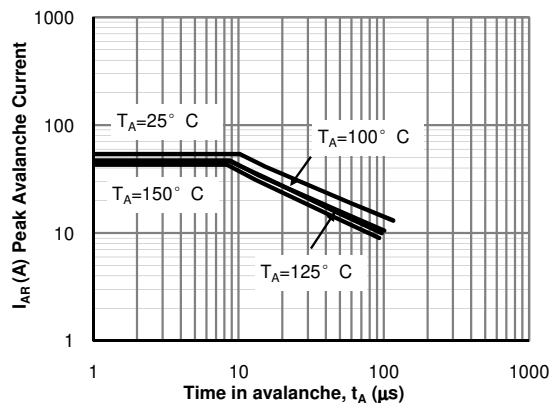


Figure 12: Single Pulse Avalanche capability (Note C)

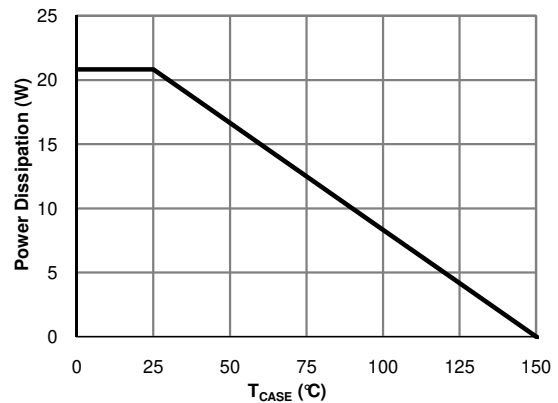


Figure 13: Power De-rating (Note F)

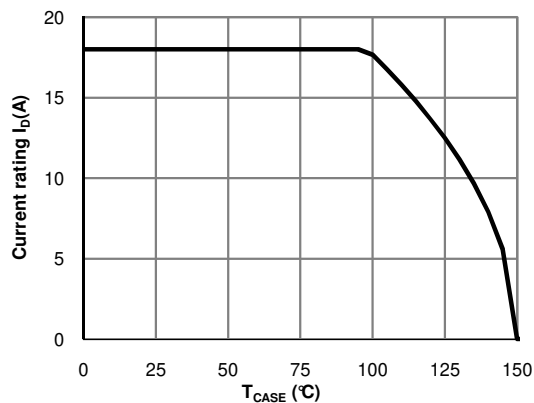


Figure 14: Current De-rating (Note F)

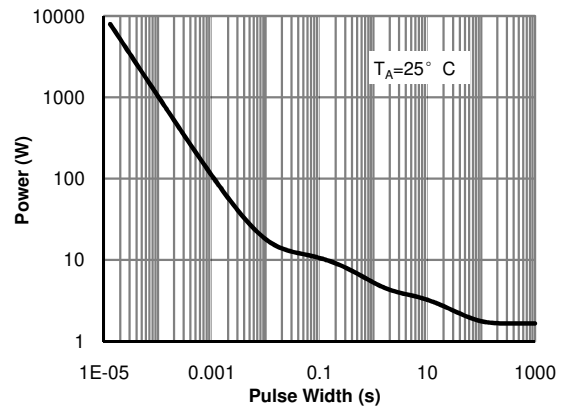


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

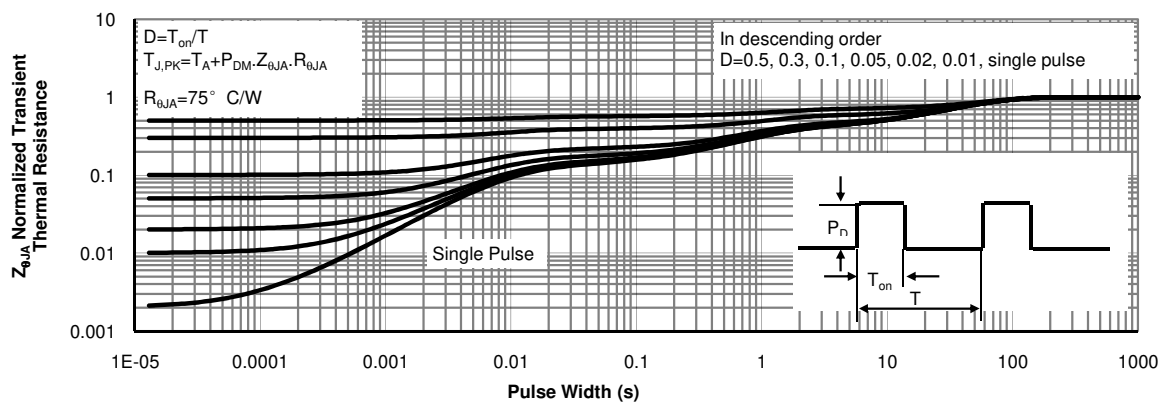
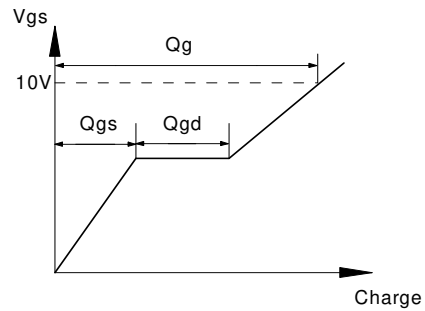
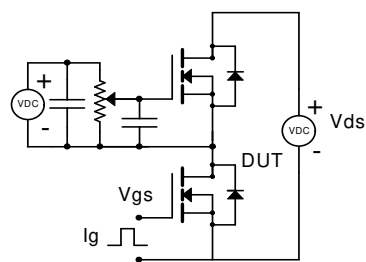
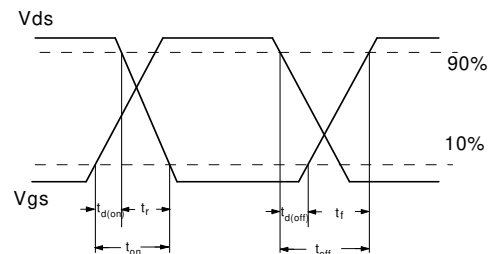
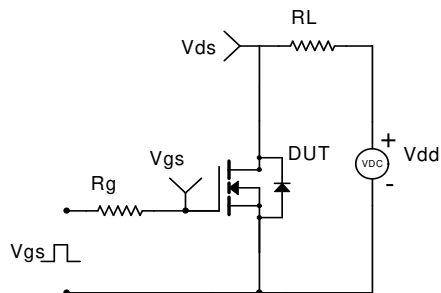


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

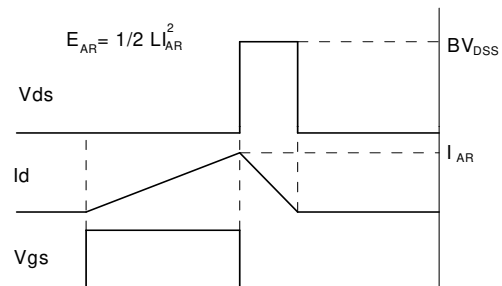
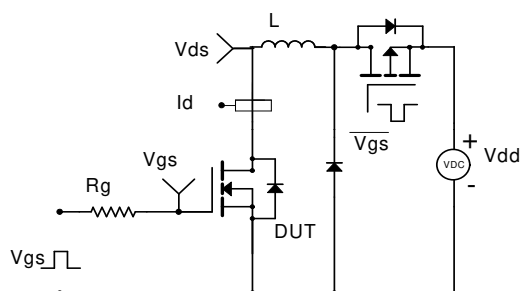
### Gate Charge Test Circuit & Waveform



### Resistive Switching Test Circuit & Waveforms



### Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



### Diode Recovery Test Circuit & Waveforms

